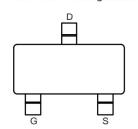


N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (mΩ)(Typ.)	I _D (A) ^a	Q _g (Typ.)		
20	24 at V _{GS} = 4.5 V	5.2	5.5.nC		
	33 at V _{GS} = 2.5 V	5.2	5.5 nC		

SOT-23 Pin Configuration



Top View

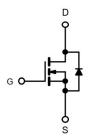
FEATURES

- DT-Trench Power MOSFET
- 100 % $R_{\rm g}$ and UIS Tested



APPLICATIONS

- · Notebook PC Core
- VRM/POL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T	A = 25 °C, unle	ess otherwise	noted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	± 8		
Continuous Drain Current (T ₁ = 150 °C)	T _A = 25 °C	- I _D	5.2 ^{b, c}		
Continuous Brain Gunerit (1) = 100 C)	T _A = 70 °C		4.2 ^{b, c}	^	
Pulsed Drain Current		I _{DM}	16	A	
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	5		
Single Pulse Avalanche Energy	L = 0.111111	E _{AS}	6	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	2.5 ^a	Α	
Maximum Power Dissipation	T _A = 25 °C	. P _D	1.6 ^{b, c}	W	
	T _A = 70 °C] ' ' ' ' ' '	1 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	t ≤ 10 s	R _{thJA}	75	90	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	63	80		

Notes: a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

Rev.A



Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit
Static			•	_		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	20			V
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$			1.2	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Oata Vallana Busin Oursel	I _{DSS}	V _{DS} = 8 V, V _{GS} = 0 V	1		1	μА
Zero Gate Voltage Drain Current		V _{DS} = 8 V, V _{GS} = 0 V, T _J = 55 °C		10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	5			Α
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 3 \text{ A}$		24	27 m/	
		V _{GS} = 2.5 V, I _D = 2 A	33 37		37	mΩ
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 3 A		30		S
Dynamic ^b						
Input Capacitance	C _{iss}			357		pF
Output Capacitance	C _{oss}	V_{DS} = 10 V, V_{GS} = 0 V, f = 1 MHz		66		
Reverse Transfer Capacitance	C _{rss}			54		
Total Gate Charge				5.5		
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 3 \text{ A}$		0.3		nC
Gate-Drain Charge	Q _{gd}			1.4		
Gate Resistance	R _g	f = 1 MHz		3		Ω
Turn-On Delay Time	t _{d(on)}			10		
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 2.5 \Omega$		20		ns
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 3 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		25		
Fall Time	t _f			10		
Drain-Source Body Diode Characteristics			•	•	,	
Continuous Source-Drain Diode Current	Is	T _A = 25 °C			5.2	A
Pulse Diode Forward Current ^a	I _{SM}				16	
Body Diode Voltage	V _{SD}	I _S = 1 A		0.6	1	V
Body Diode Reverse Recovery Time	t _{rr}	L = 2 A di/dt = 100 A/vs T = 05 °C		20	30	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$I_F = 3 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		7		nC

Notes:

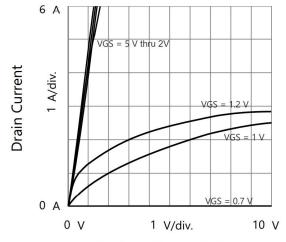
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

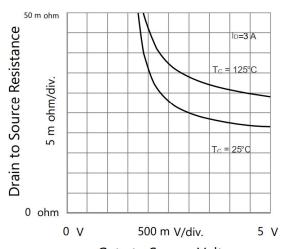
b. Guaranteed by design, not subject to production testing.



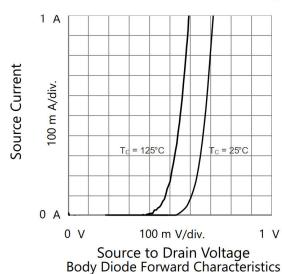
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

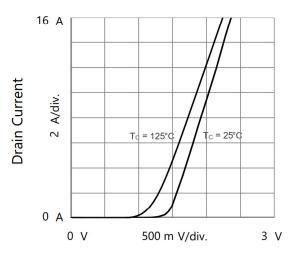


Drain to Source Voltage Output Characteristics

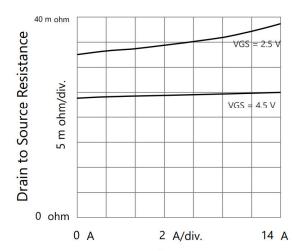


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

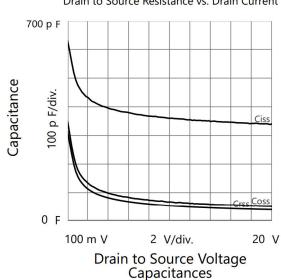




Gate to Source Voltage Transfer Characteristics



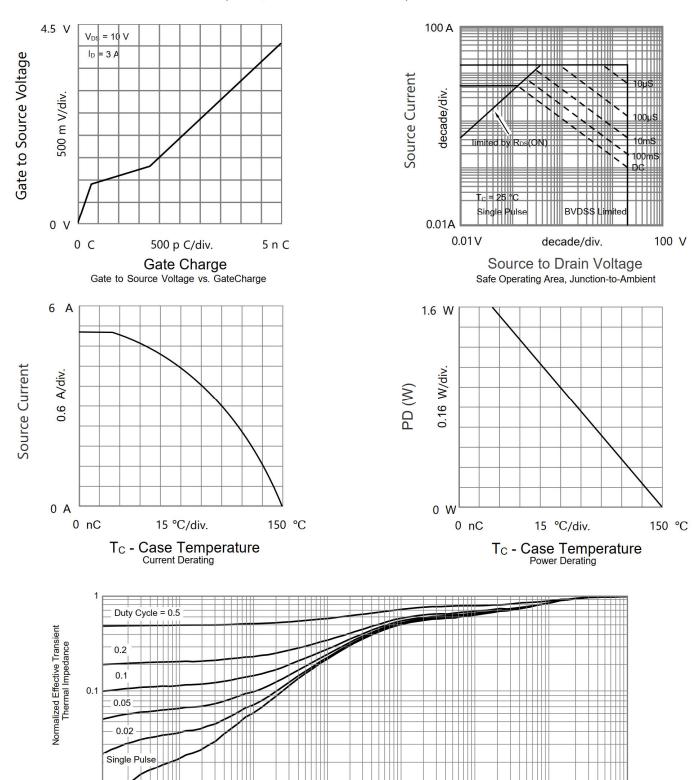
Drain Current
Drain to Source Resistance vs. Drain Current



0.01 ____

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TYPICAL CHARACTERISTICS (25 C, unless otherwise noted)



Square Wave Pulse Duration (s)

Normalized Thermal Transient Impedance, Junction-to-Ambient

10-2

10-3

1000

100





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